

Notice of References Cited	Application/Control No. 10/581,133		Applicant(s)/Patent Under Reexamination HIKMET ET AL.	
	Examiner Sikha Roy		Art Unit 2879	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,065,285	06-2006	Chen et al.	385/141
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	'Composite thin films of CdSe nanocrystals and a surface passivating/electron transporting block co-polymer:Correlations between film microstructure by transmission electron microscopy and electroluminescence' H Mattoussi et al., Journal of Applied Physics, Vol. 86, No. 8, 15 October 1999
	V	"Quantum Dots Tailored with Poly(para-phenylene vinylene) Skaff et al. JACS, 126:11322-11325(2004)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.